

InP crystal

Solid state detector using indium for
pp/⁷Be solar neutrino measurement

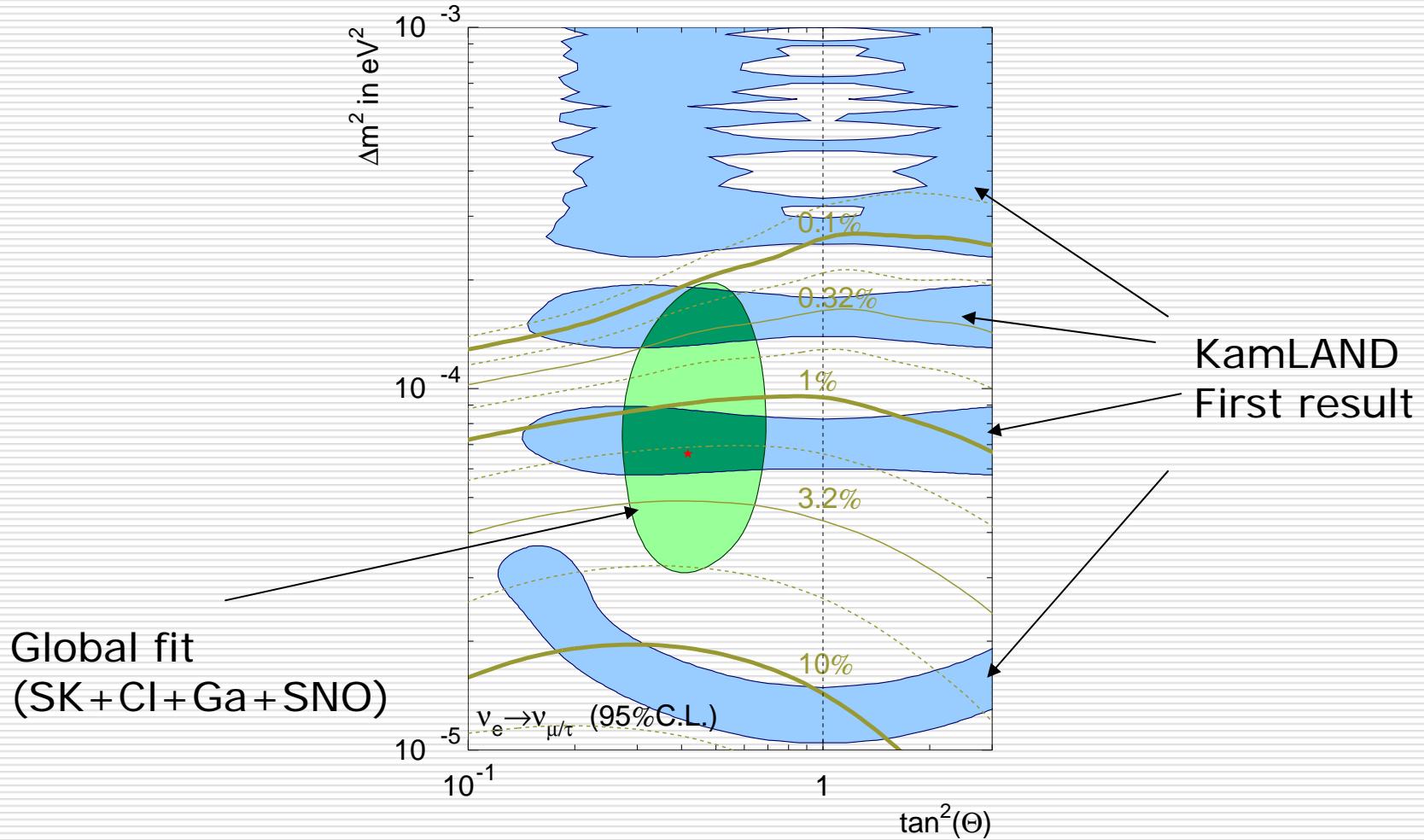
Supported by Grant-in Aid for Scientific Research (B)
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Status of Solar Neutrino Oscillation



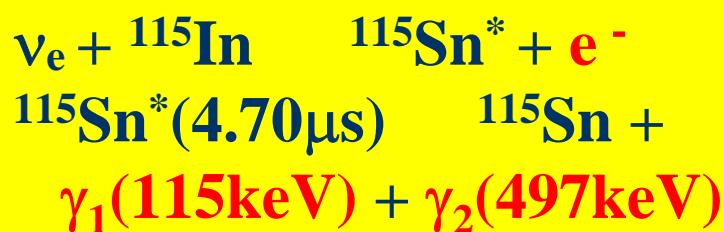
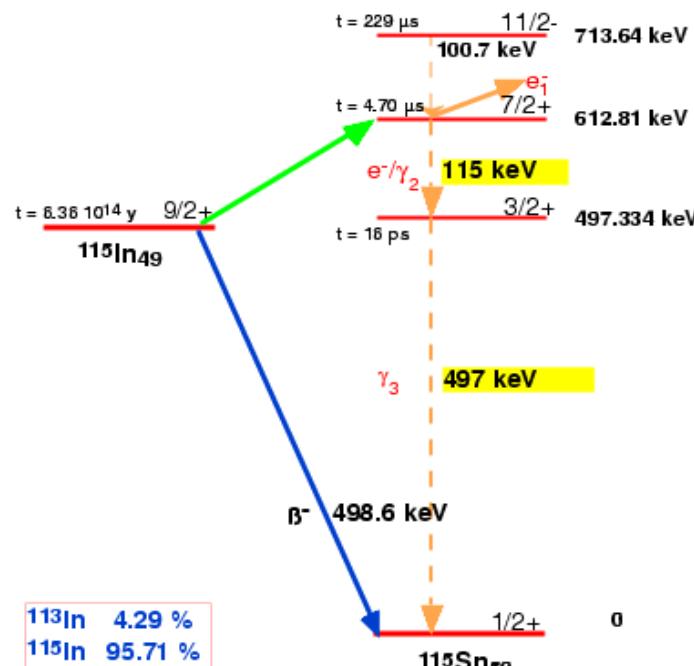
Projects to detect low energy solar neutrinos

- ν_e elastic scattering experiment
 - XMASS (Liquid Xe scintillator)
 - CLEAN (Liquid Neon scintillator)
 - HERON (Liquid Helium at 50mK + scintillation)
 - TPC (Helium + CH_4 gas chamber)
 - Genius (Ge detector in LN_2)
 -

- ν_e charged current experiment
 - LENS (In/Ye loaded liquid scintillator)
 - SIREN (^{160}Gd loaded liquid scintillator)
 - MOON (^{100}Mo)
 -

Neutrino capture using indium and their advantages

R.S.Raghavan Phs.Rev.Lett37(1976)259



- Real-time measurement
- ν energy measurable ($E_e = E_\nu - 114.2\text{keV}$)
- 3 fold coincidence to extract neutrino signal
- β -decay from ^{115}In ($\tau_{1/2} = 6 \times 10^{14}\text{yr}$)
- Correlated chance coincidence-Bremsstrahlung
- Correlated chance coincidence impurities

History of InP SSD development

- Y.Suzuki et al., Indium Phosphide solid state detector NIMA 275(1988)142

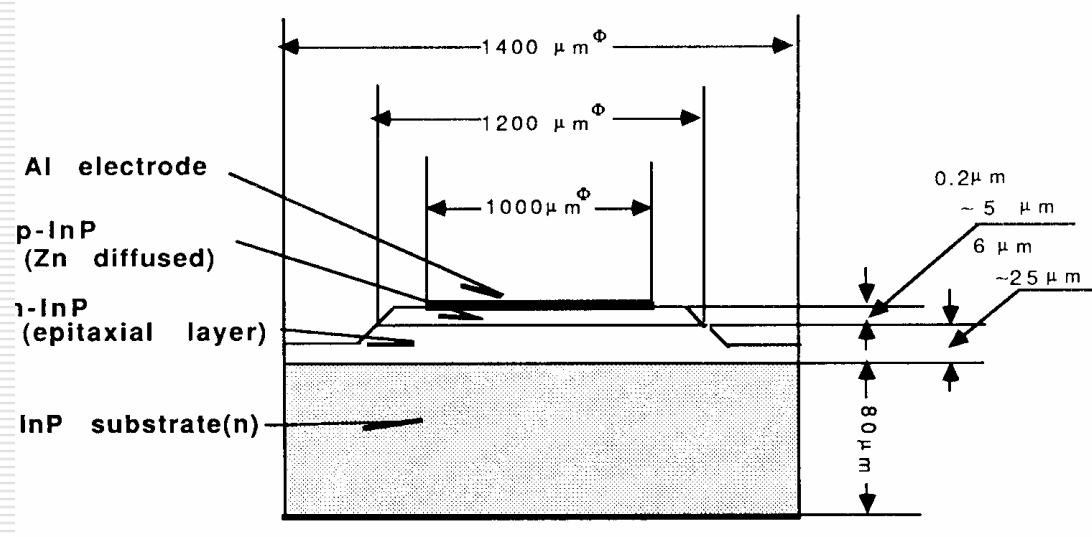


Fig. 1. Schematic view of the InP photodiode.

CCE is 60% for α particle and 76% for 60keV γ -ray

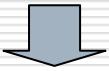
Detector size is small (limited by an epitaxial growth)

Current status of InP SSD development

- H.El-Abbassi et al., NIMA 466(2001)46
 - VGF semi-insulating Fe-doped InP bulk detector
 - CCE~72% for 5.46MeV alpha particle
- F.Dubecky et al., NIMA487(2002)27
 - VGF SI InP with Schottky electrodes
 - volume 0.25mm³ CCE~82% with 14% (FWHM) of resolution for 60keV gamma
- A.Owens et al., NIMA 487(2002)435
 - SI Fe-doped InP detector for X-ray measurement
 - size 3mmx3mmx180mm P⁺ contact
 - 2.5keV (FWHM) for 5.9keV and 12keV for 88keV of resolution at -60 degree

Semi-Insulating (SI) InP detector

- well established material
- $\langle A \rangle \sim 80.2$ (almost same as Ge/GaAs)
- band gap 1.34eV (can be used in RT)
- high resistance $(0.5 \sim 0.94) \times 10^8 \text{ } \cdot \text{cm}$
- fast mobility $2000 \sim 2200 \text{ cm}^2 / \text{V} \cdot \text{s}$



Possible work as bulk type detector

cf. 10cm x 10cm x 500 μm in thickness 24g



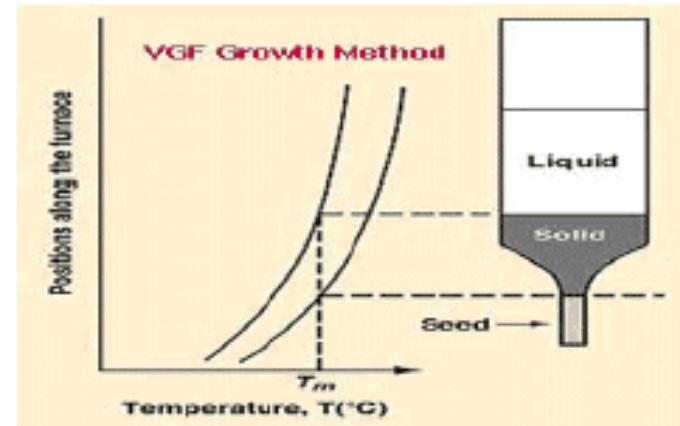
In 2ton would capture 0.5ppv_e / day ~100,000 units

InP crystal made by Vertical Gradient Freeze (VGF)

[H.El-Abbassi et al., NIMA 466\(2001\)47](#)

Comparison of VGF, LEC and HB growth method

	VGF	LEC	HB
SI Wafers	Yes	Yes	No
SC Wafers	Yes	No	Yes
EPD (Crystal Defects)	V.Low	High	Low
Stress	Low	High	Medium
Uniformity	Good	Fair	Poor
Diameter Scale Up	Good	Good	Poor

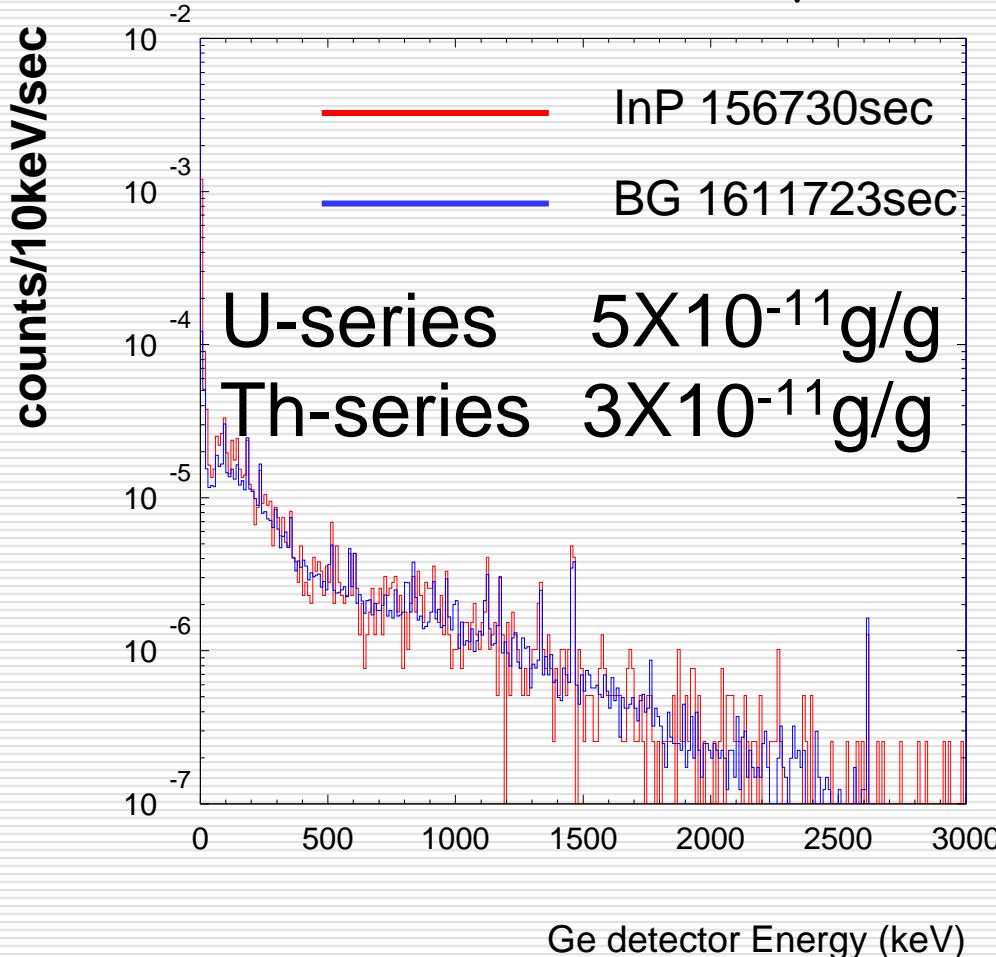


specifications as given by AXT

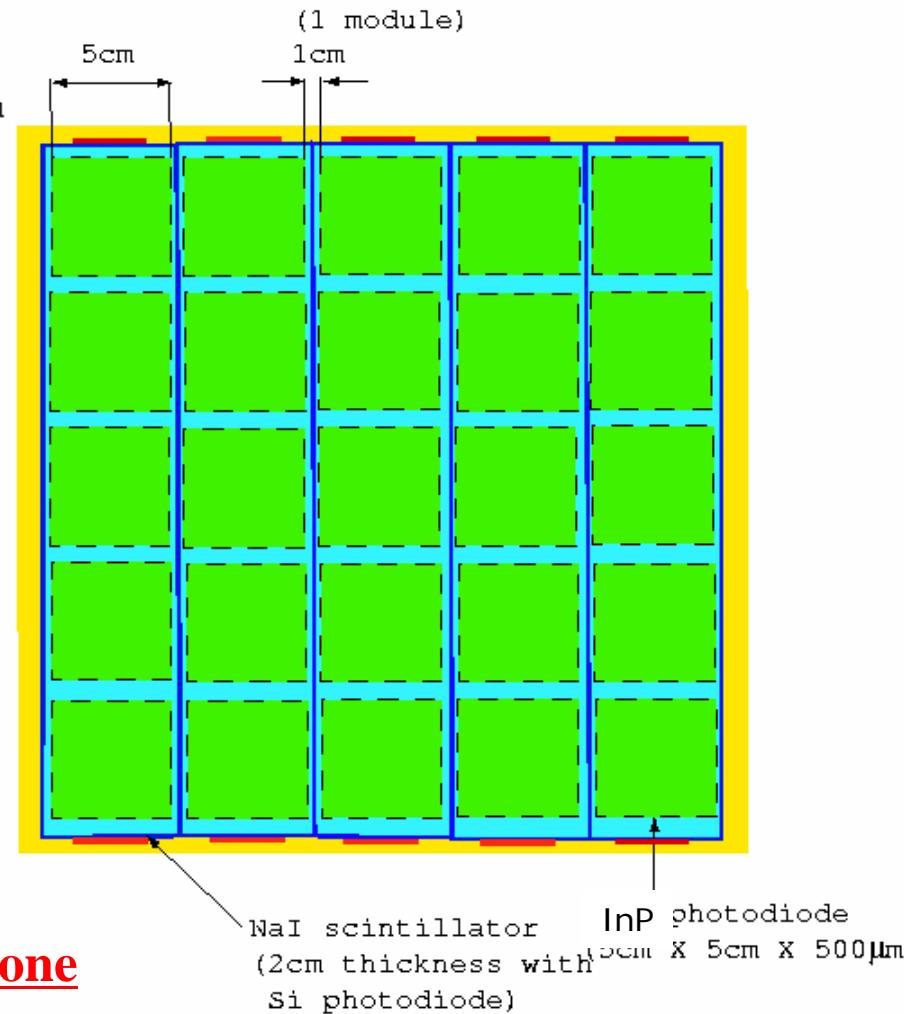
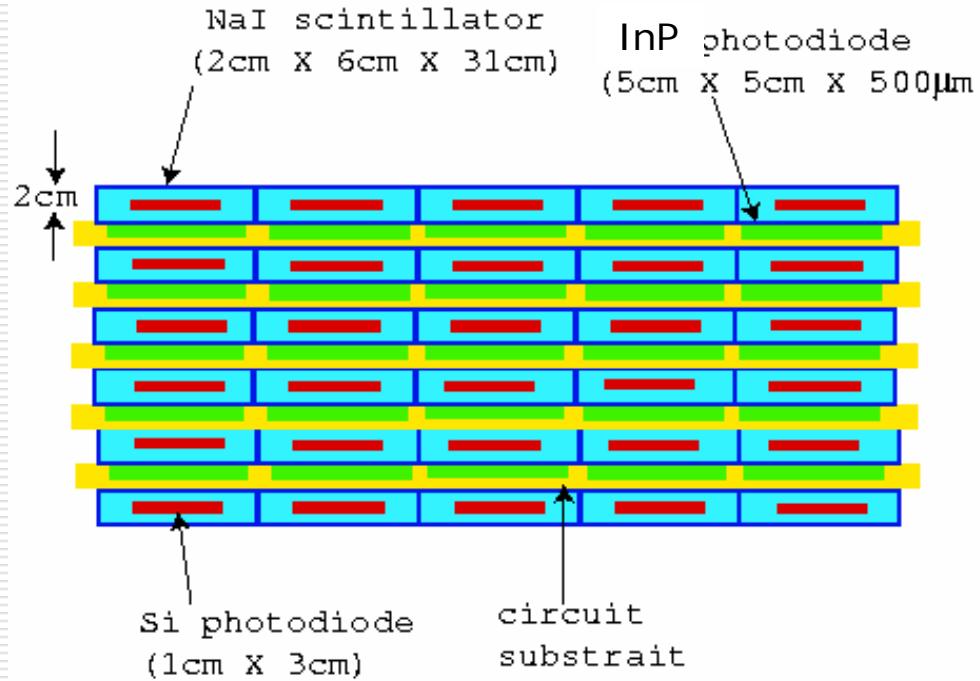
resistivity	$1.1 - 2.2 \times 10^7 \Omega\text{cm}$
mobility	$2600-2700 \text{ cm}^2/\text{Vs}$
thickness	$350 \pm 25 \mu\text{m}$
Fe concentration	

Background measurement of SI InP substrait

diameter 5cm thickness 500 μ m mass 1.5g



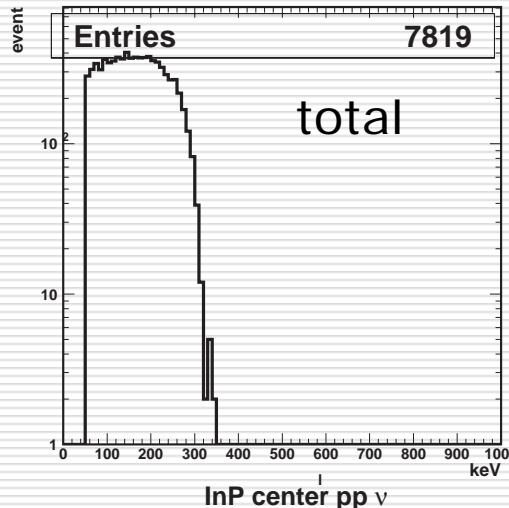
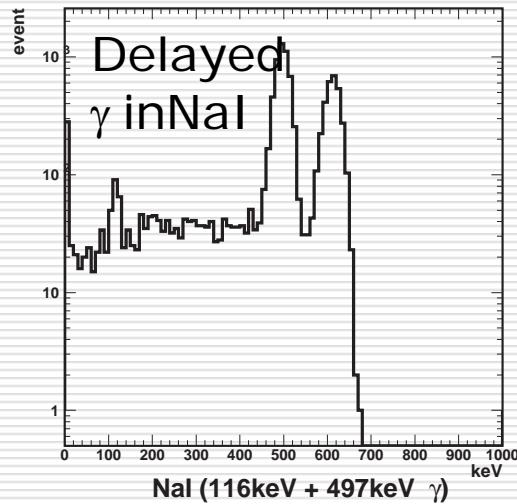
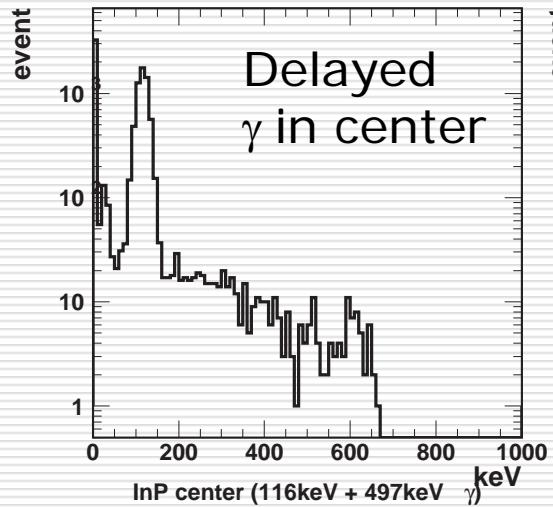
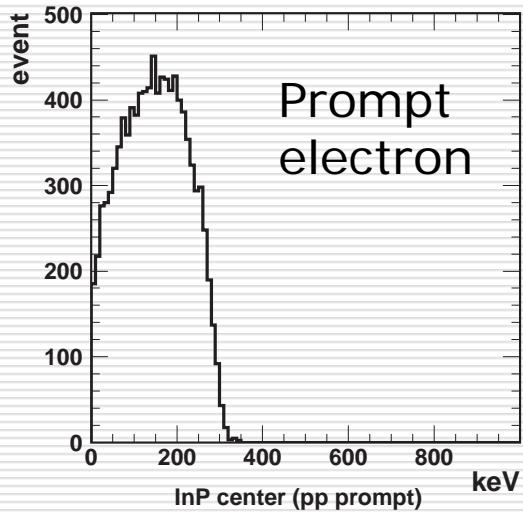
Basic idea of InP solid state detector for solar neutrino measurements



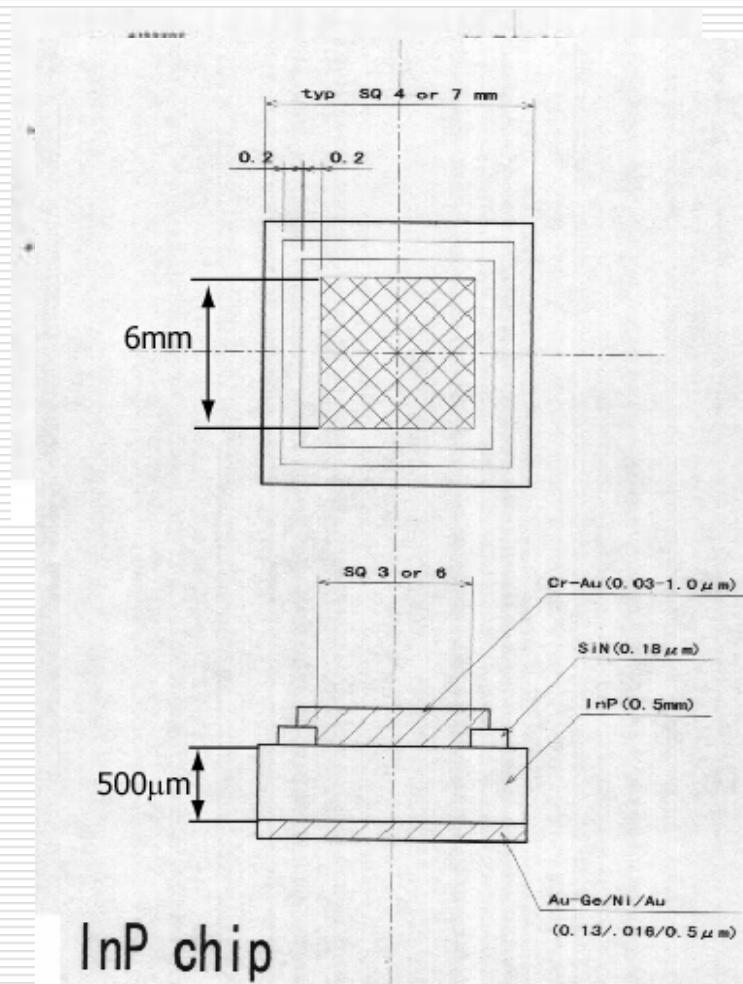
High energy resolution, high granularity
High speed read out, No quenching

→ **High BG reduction could be done**

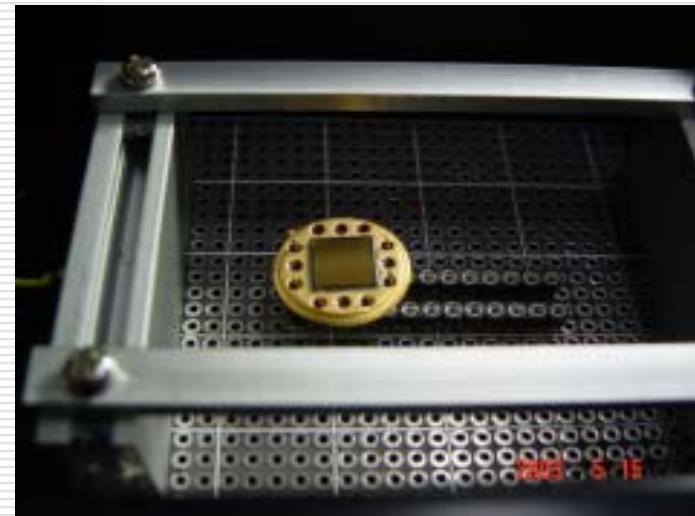
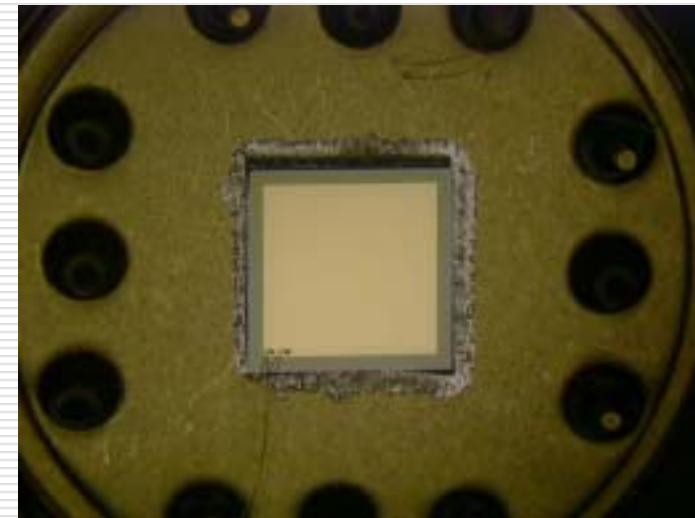
Monte Carlo signal simulation



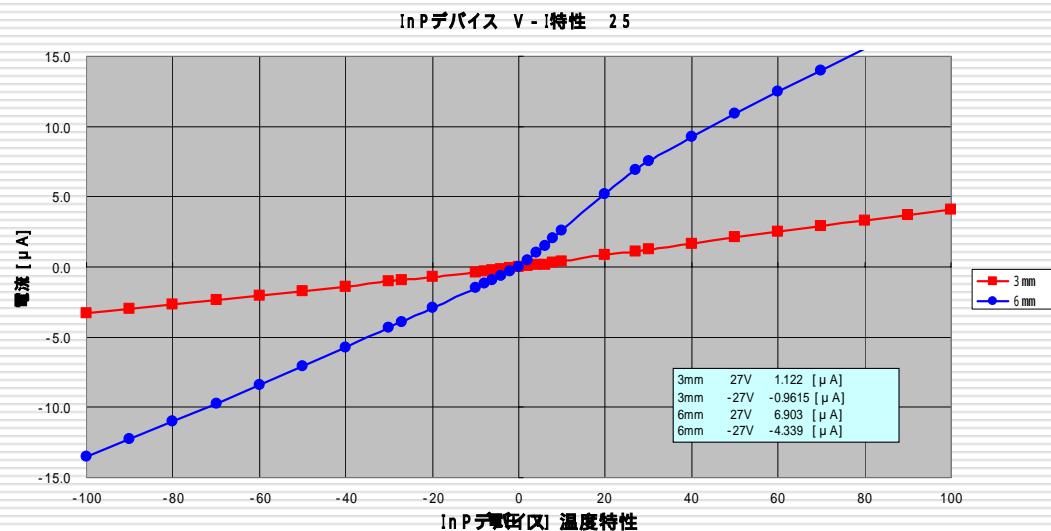
InP SI proto-type detector (phase-I)



InP chip
(presented by Hamamatsu photonics)

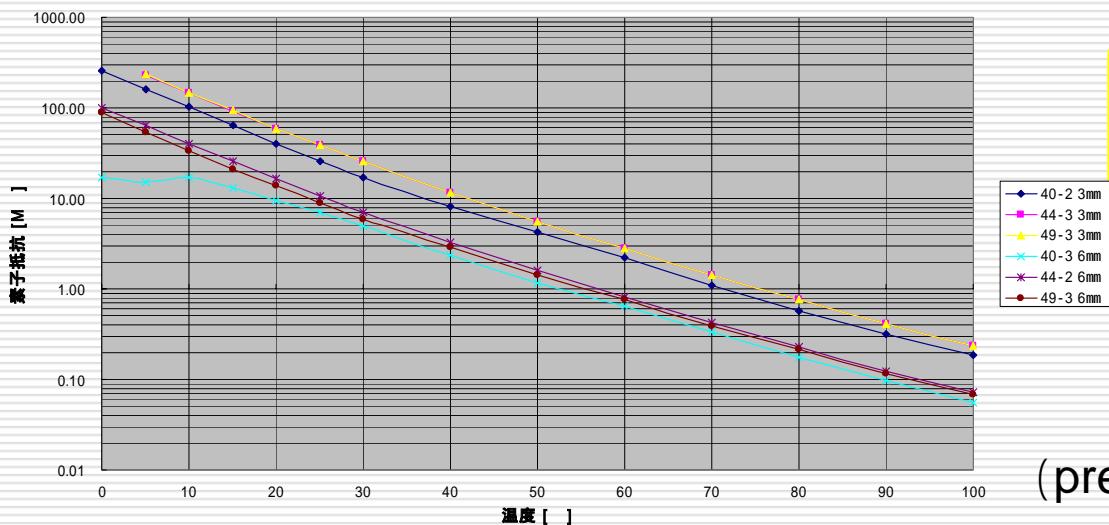


Property of proto-type detector



Dark current can be reduced by lowering the temperature.

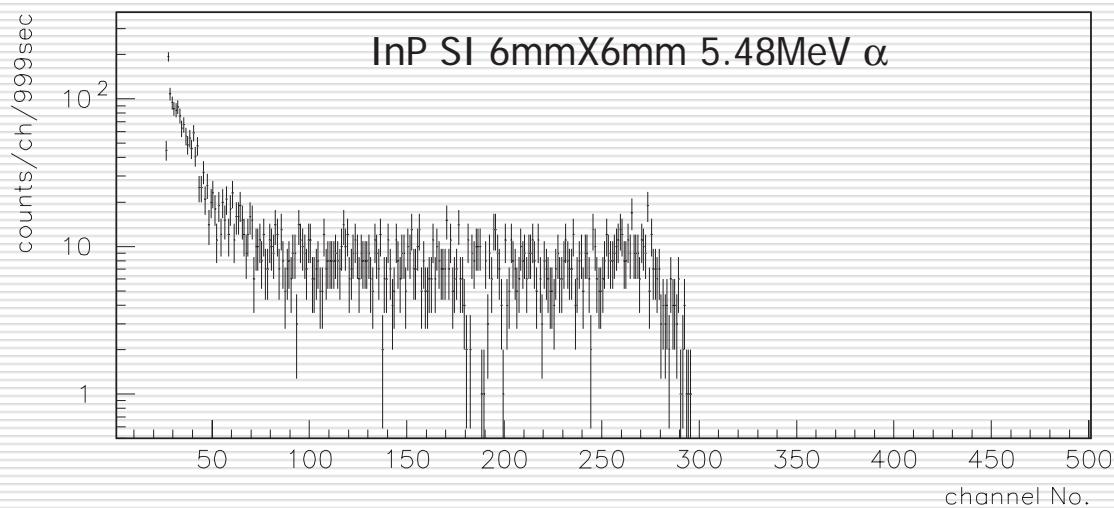
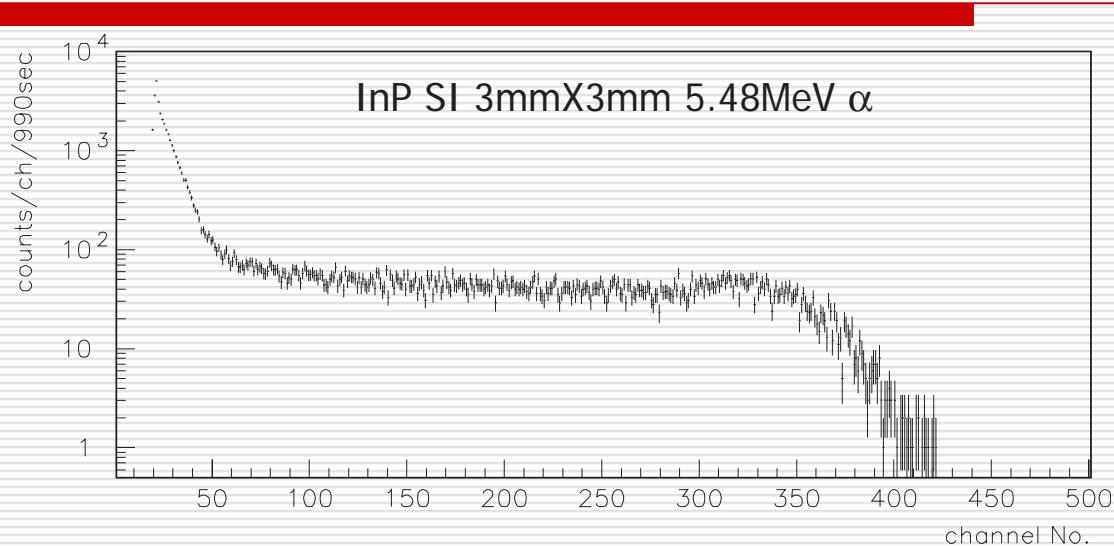
$$I[A] = T^{2/3} \exp(-E_g/2k_B T)$$



0.018 μA for 36mm² InP
@ 100V and -40degree

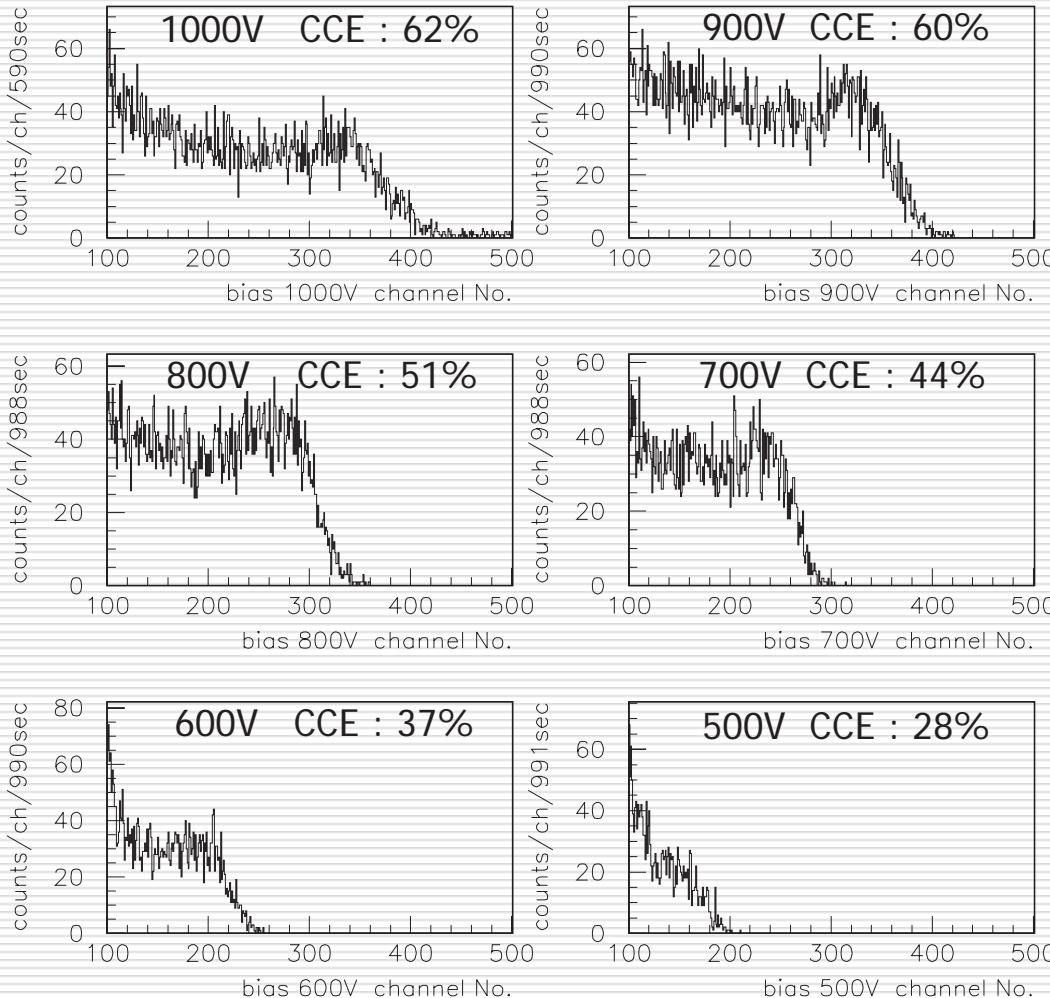
(presented by Hamamatsu Photonics)

Response for alpha particle



signal could be seen,
however no single
peak

Charge Collection Efficiency

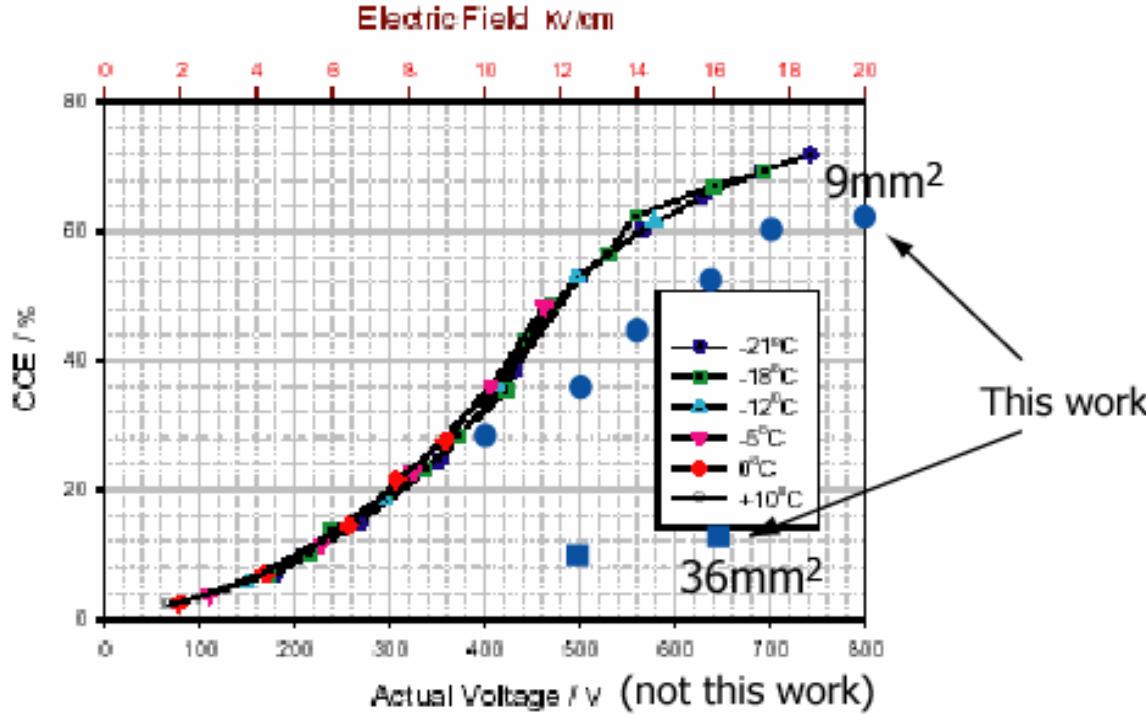


electron/hole pair production energy for InP : **4.2eV**

Comparison with UK group

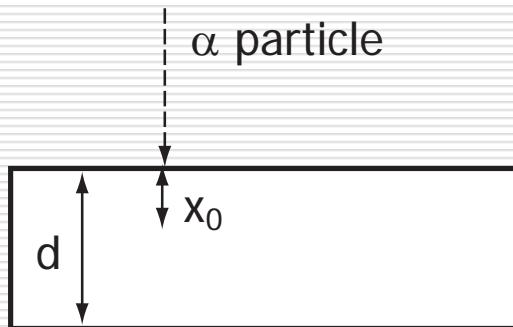
[H.El-Abbassi et al., NIMA 466\(2001\)47](#)

-ve bias (electron drift)



Maximum CCE is obtained by 60% for 9mm² InP
(but 13% for 36mm² InP)

Explanation of CCE for SI InP



μ : mobility [$\text{m}^2\text{V}^{-1}\text{s}^{-1}$]
 v : carrier velocity [ms^{-1}]
 E : electric field [Vm^{-1}]
 V_0 [volts] d : thickness of SI InP
 x_0 : range of α particle

$$E = V_0/d \quad v = \mu E = \mu V_0/d$$

$$\text{average length } L = \tau v = \mu \tau V_0 / d \quad \tau : \text{carrier lifetime [s]}$$

$\mu \tau$ is measured by H.El-Abassi et al. NIMA466(2001)47

$$\mu \tau = 5 - 8 \times 10^{-7} \text{ [cm}^2\text{V}^{-1}\text{]} (@-21 \text{ to } 19 \text{ degree})$$

$$\begin{aligned}
 \text{Thus } L &= 5 \times 10^{-7} [\text{cm}^2\text{V}^{-1}] \times 1000 [\text{V}] / 500 [\mu\text{m}] \\
 &= 0.01 \text{ [cm]} \gg x_0 (\sim 16 \mu\text{m} \text{ in InP 4MeV } \alpha)
 \end{aligned}$$

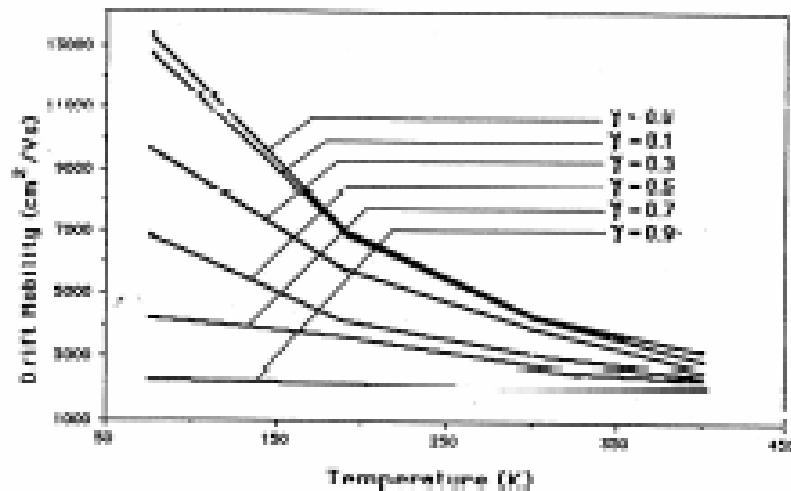
However, it means not enough for the entire volume to collect all charge

How to get higher CCE

For full depletion of detector volume,

- Increase bias voltage
- Lower temperature ($\mu\tau$ becomes large, and also BG should be reduced)

Extrapolated Low-Field Electron Drift Mobility for InP



Ref: J. Costa and A.Pczalski, *J. Appl. Phys.* **66**(2), (1989) p674-679

Results and Future

- Active area 9mm^2 and 36mm^2 with $500\mu\text{m}$ thickness proto-type InP detector were tested
- Alpha particle signal was clearly seen
- CCE is obtained by 60% for 9mm^2 and 13% for 36mm^2
- New proto-type detectors (phase-II) will come soon
 - 36mm^2 SI InP with a peltier cooler
 - 36mm^2 SI InP applied by schottky barrier
cf $38.5\text{mm}^2 \times 140\mu\text{m}$ detector NIMA458(2001)400
- If CCE achieve over 80%, then large active area with 900mm^2 detector (phase-III) will be tested within this year

Proto-type InP detector (phase-II) with Peltier cooler



外形図 (単位 : mm)

